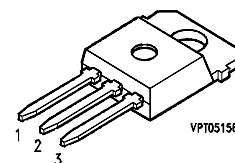


### Cool MOS™ Power Transistor

- Worldwide best  $R_{DS(on)}$  in TO 218
- N-Channel
- Enhancement mode
- Ultra low gate charge
- Avalanche rated
- dv/dt rated
- 150°C operating temperature



1	2	3
G	D	S

Type	$V_{DS}$	$I_D$	$R_{DS(on)}$	Marking	Package	Ordering Code
SPHX0N60S5	600 V	47.3 A	70 mΩ	X0N60S5	P-TO218-3-1 -	-

**Maximum Ratings**, at  $T_j = 25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Drain source voltage	$V_{DSS}$	600	V
Continuous drain current $T_C = 25\text{ °C}$ $T_C = 100\text{ °C}$	$I_D$	47.3 30	A
Pulsed drain current $T_C = 25\text{ °C}$	$I_{D\text{ puls}}$	95	
Avalanche energy, single pulse $I_D = 47.3\text{ A}$ , $V_{DD} = 50\text{ V}$ , $R_{GS} = 25\text{ Ω}$	$E_{AS}$	1800	mJ
Avalanche current (periodic, limited by $T_{jmax}$ )	$I_{AR}$	tbd	A
Avalanche energy (10 kHz, limited by $T_{jmax}$ )	$E_{AR}$	tbd	mJ
Reverse diode dv/dt $I_S = 47.3\text{ A}$ , $V_{DS} < V_{DSS}$ , $di/dt = 100\text{ A/μs}$ , $T_{jmax} = 150\text{ °C}$	dv/dt	6	KV/μs
Gate source voltage	$V_{GS}$	±20	V
Power dissipation, $T_C = 25\text{ °C}$	$P_{tot}$	415	W
Operating temperature	$T_j$	-55 ... +150	°C
Storage temperature	$T_{stg}$	-55 ... +150	
IEC climatic category; DIN IEC 68-1		55/150/56	

### Electrical Characteristics

Parameter at $T_j = 25\text{ °C}$ , unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	

### Thermal Characteristics

Thermal resistance, junction - case	$R_{thJC}$	-	-	0.3	K/W
Thermal resistance, junction - ambient (Leaded and through-hole packages)	$R_{thJA}$	-	45	-	
SMD version, device on PCB: @ min. footprint @ 6 cm <sup>2</sup> cooling area <sup>1)</sup>	$R_{thJA}$	- -	- -	- -	

### Static Characteristics

Drain- source breakdown voltage $V_{GS} = 0\text{ V}$ , $I_D = 0.25\text{ mA}$	$V_{(BR)DSS}$	600	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 2.7\text{ mA}$ , $T_j = 25\text{ °C}$ $I_D = 2.7\text{ mA}$ , $T_j = 150\text{ °C}$	$V_{GS(th)}$	3.5 tbd	4.5 -	5.5 -	
Zero gate voltage drain current, $V_{DS} = V_{DSS}$ $V_{GS} = 0\text{ V}$ , $T_j = -40\text{ °C}$ $V_{GS} = 0\text{ V}$ , $T_j = 25\text{ °C}$ $V_{GS} = 0\text{ V}$ , $T_j = 150\text{ °C}$	$I_{DSS}$	- - -	- 0.5 -	0.1 1 tbd	μA
Gate-source leakage current $V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$	$I_{GSS}$	-	10	100	nA
Drain-Source on-state resistance $V_{GS} = 10\text{ V}$ , $I_D = 30\text{ A}$	$R_{DS(on)}$	-	tbd	70	mΩ

<sup>1</sup> Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70μm thick) copper area for drain connection. PCB is vertical without blown air.

### Electrical Characteristics

Parameter at $T_j = 25\text{ }^{\circ}\text{C}$ , unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Transconductance $V_{DS} \geq 2 * I_D * R_{DS(on)max}$ , $I_D = 30\text{ A}$	$g_{fs}$	-	tbd	-	S
Input capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{iss}$	-	7800	tbd	pF
Output capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{oss}$	-	5000	tbd	
Reverse transfer capacitance $V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{rss}$	-	265	tbd	
Turn-on delay time $V_{DD} = 350\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 47.3\text{ A}$ , $R_G = 1.3\text{ }\Omega$	$t_{d(on)}$	-	tbd	tbd	ns
Rise time $V_{DD} = 350\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 47.3\text{ A}$ , $R_G = 1.3\text{ }\Omega$	$t_r$	-	tbd	-	
Turn-off delay time $V_{DD} = 350\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 47.3\text{ A}$ , $R_G = 1.3\text{ }\Omega$	$t_{d(off)}$	-	tbd	tbd	
Fall time $V_{DD} = 350\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 47.3\text{ A}$ , $R_G = 1.3\text{ }\Omega$	$t_f$	-	tbd	-	

### Electrical Characteristics

Parameter at $T_j = 25\text{ °C}$ , unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	

### Gate Charge Characteristics

Gate-source charge $I_D = 47.3\text{ A}$ , $V_{DD} = 400\text{ V}$	$Q_{gs}$	-	tbd	-	nC
Gate-drain charge $I_D = 47.3\text{ A}$ , $V_{DD} = 400\text{ V}$	$Q_{gd}$	-	tbd	-	
Total gate charge $V_{DD} = 400\text{ V}$ , $I_D = 47.3\text{ A}$ , $V_{GS} = 0\text{ to }10\text{ V}$	$Q_G$	-	260	tbd	

### Reverse Diode

Continuous source current $T_C = 25\text{ °C}$	$I_S$	-	-	47.3	A
Pulsed source current $T_C = 25\text{ °C}$	$I_{SM}$	-	-	95	
Inverse diode forward voltage $V_{GS} = 0\text{ V}$ , $I_F = 47.3\text{ A}$	$V_{SD}$	-	tbd	1.2	V
Reverse recovery time $V_R = 100\text{ V}$ , $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$	$t_{rr}$	-	tbd	-	ns
Reverse recovery charge $V_R = 100\text{ V}$ , $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$	$Q_{rr}$	-	tbd	-	$\mu\text{C}$

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